An Electron Tunneling Study of Superconductivity in Amorphous Sn$_{1-x}$Cu$_x$ Thin Films

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The amorphous phase of Sn would have a superconducting transition temperature near 8 K, much higher than that of crystalline Sn with $T_c = 3.5$ K. To obtain the amorphous phase, however, it is necessary to use a Sn alloy, usually Cu, and quench condense the alloy films onto a liquid He temperature substrate. Alloying with Cu reduces the superconducting transition temperature almost linearly with Cu concentration with an extrapolation of $T_c$ to zero for $x = 0.85$. Analysis of the tunneling characteristics between a normal metal electrode with an insulating barrier and superconducting amorphous Sn-Cu films provides detailed information on the changes in the electron-phonon coupling which determines $T_c$ in these alloys. The change from very strong electron-phonon coupling to weak-coupling with the increase in Cu content of amorphous Sn-Cu alloys for the range 0.08 $\leq x \leq 0.41$ is presented and discussed in terms of theories of the electron-phonon coupling in disordered metals.

I. INTRODUCTION

It has been shown by many researchers that amorphous metals have dramatically different superconducting characteristics from their crystalline counterparts. Knorr and Barth found that the transition temperature, $T_c$, of an amorphous Sn$_{0.9}$Cu$_{0.1}$ alloy was almost 7 K, as opposed to 3.6 K for crystalline Sn. Their tunneling measurements also showed that it is a strong-coupling superconductor. Leitz and Dutzi and Buckel reported that the $T_c$ of amorphous Sn-Cu alloys decreased linearly with the Cu concentration. Heat capacity measurements of amorphous Sn$_{1-x}$Cu$_x$ films (0.47 $< x < 0.75$) determined that $\theta_D$ increases with increasing copper concentration. The results were interpreted in terms of the McMillan expression for $T_c$,

$$ T_c = \frac{\theta_D}{1.45} \exp \left[ - \frac{1.04(1 + \lambda)}{\lambda - \mu^*(1 + 0.62\lambda)} \right] $$

(1)

where $\lambda$ is the electron-phonon coupling constant, $\mu^*$ is the repulsive Coulomb electron-electron interaction, and $\theta_D$ is the Debye temperature. With the assumption of a constant value for $\mu^*$, they concluded that while $\theta_D$ was increasing, evidently $\lambda$ was changing in such a way as to cause a linear decrease in $T_c$. Dynes has developed a better approximation for the transition temperature,

$$ T_c = \frac{\langle \omega \rangle}{1.20} \exp \left[ - \frac{1.04(1 + \lambda)}{\lambda - \mu^*(1 + 0.62\lambda)} \right] $$

(2)

where $\langle \omega \rangle$ is the average phonon energy, in which $\langle \omega \rangle$ doesn’t necessarily scale with $\theta_D$. To identify the parameters responsible for the linear decrease of $T_c$ with the copper concentration for this strong-coupling simple metal amorphous superconducting alloy, and investigate in detail the expected change from very strong-coupling to weak-coupling behavior in an amorphous metal alloy, we present tunneling measurements which have been analyzed to provide $\langle \omega \rangle$, $\lambda$, $\mu^*$ and the frequency dependence of $\alpha^2 F(\omega)$ for 0.08 $\leq x \leq 0.41$.

II. EXPERIMENTAL DETAILS

The UHV deposition system and cryostat have been described previously, but the liquid-helium thermal shield has been modified to include a movable mask consisting of the horizontal and vertical slits needed to form the tunnel junctions. This allowed the entire junction to be fabricated in the UHV system and oxidation of the counterelectrode in pure O$_2$ at an elevated temperature instead of
in ambient room air. This in situ fabrication technique was essential to preparation of high quality junctions with reproducible junction resistance and low leakage characteristics.

The tunneling base electrode was made by evaporating aluminum through the horizontal slit in the liquid-helium shutter. The resulting film, 0.25 mm wide and typically 1300Å thick, was then oxidized in 1 atmosphere of dry oxygen at ~85°C for about 14 hours, resulting in a barrier oxide layer about 23Å thick. The system was then pumped overnight to a pressure of approximately $10^{-9}$ Torr after which the substrate was heated to ~60°C for two hours and then immediately cooled to liquid He temperature. Four SnCu films were e-beam evaporated sequentially, each deposition from the liquid-helium shutter. The resulting film, 0.5 mm wide and typically 400Å thick, was then oxidized in 1 atmosphere of dry oxygen at ~85°C for two hours and then immediately cooled to liquid He temperature. The input parameters to the McMillan-Rowell inversion program are the energy gap, $\Delta_0$, and the deviation from a BCS-like superconductor. The deviation is calculated using the measured $\Delta_0$ and the normalized tunneling density of states obtained from the raw data. Since the deviation strongly depends on $\Delta_0$ in the low bias voltage region where the BCS density of states is changing rapidly, an incorrect determination of $\Delta_0$ can have a large effect on the deviation. This, in turn, can cause large differences in $\alpha^2 F(\omega)$ and $\mu^*$ calculated by the inversion program. Thus, an accurate determination of $\Delta_0$ is essential in order to obtain meaningful results from the inversion program.

The determination of the energy gap is straightforward, involving the measurement of the leakage conductance and the superconducting state first derivative in the region of the gap, and was usually measured immediately after the normal state derivative. The substrate was cooled to the lowest temperature possible, ~1.5 Kelvin, while the resistance of the aluminum counterelectrode waas monitored to make sure it showed no signs of superconductivity. The leakage conductance was measured by balancing the bridge at zero bias using the smallest AC signal possible, typically less than 0.5μV. This gives $R_{\text{max}}$, which is directly related to the leakage conductance since it should be infinite. For “good” junctions, the leakage conductance was usually less than 4% of the normal state. Zero bias was achieved by disconnecting the current sweep generator. Also, the filters were disconnected since the junction resistance was an appreciable fraction of the filters’ reactance.

The superconducting state first derivative was measured with a lock-in amplifier with an AC signal typically less than 5μV and a 300 mscs time constant. A very rough estimate of the gap $\Delta_0$ was obtained by determining the voltage at which the resistance matched the high bias resistance. The bias voltage was swept starting at about $-3\Delta_0$, through zero, to about $3\Delta_0$, taking typically 20 to 30 minutes with data points about every 2μV. The sensitivity of the lock-in amplifier was set such that the lock-in didn’t go off scale until the absolute value of the bias voltage was less than $\Delta_0$. The normal and superconducting first derivative data were then smoothed and interpolated with an increment of 5μV. Data where the lock-in was off scale was not used.

The energy gap was basically determined from fitting the tunneling density of states, $N_T$, to the BCS density of states. This, however, is complicated by three factors: 1) the tunneling density of states is shifted slightly with respect to bias voltage due to the time constant of the lock-in amplifier; 2) the normal state first derivative data is shifted vertically from that of the superconducting state because the resistance of the film over the oxide layer is not negligible compared to the junction resistance; 3) there is a small leakage conductance. The leakage conductance is easily accounted for.
for by subtracting it from both the superconducting and normal state data. In terms of what is measured,

\[ N_T = \frac{\sigma_S - \sigma_L}{\sigma_N - \sigma_L} = \frac{R_S - R_N}{R_S - R_{max}} \]

where \( R_N(R_S) \) is the first derivative in the normal (superconducting) state. The vertical shift in the normal state data is easily accounted for by introduction of a variable parameter, \( y_{\text{offset}} \), and a change of variable, \( R'_N = R_N + y_{\text{offset}} \).

The temperature dependent tunneling density of states in the BCS approximation is given by

\[ N_T(E,V,T) = \frac{dI_{\text{dc}}/dV}{dI_{\text{dc}}/dV} = \int_{-\infty}^{\infty} dE N_1(E) d\frac{f(E-eV)}{N_1(0)} \]

\[ = \beta \int_{-\infty}^{\infty} dE N_{\text{BCS}}(E) \frac{e^{\beta(E-eV)}}{(1+e^{\beta(E-eV)})^{3/2}} \]

where \( N_{\text{BCS}}(E) = |E|/(E^2 - \Delta_0^2)^{1/2} \), and \( \beta = (0.08617T)^{-1} \) in units of meV\(^{-1} \). The shift in the density of states with bias voltage is accounted for by introduction of another variable parameter, \( x_{\text{offset}} \), and a change of variable, \( E' = E + x_{\text{offset}} \). The variables \( \Delta_0 \), \( y_{\text{offset}} \), and \( x_{\text{offset}} \) were varied to give the best least squares fit between equations (3) and (4). This procedure is repeated for at least three different sets of data and the resulting \( \Delta_0 \)'s compared for consistency.

**B. First Derivative Measurement**

The tunneling density of states involves the measurement of the first derivatives in the normal and the superconducting states over the phonon frequency range. This is similar to the measurements needed to determine the energy gap, and in fact, the normal state first derivative had to be measured prior to actually determining the energy gap. Figure 1 is an example of the raw data for Sn\(_{0.72}\)Cu\(_{0.22}\). At this stage, the AC signal was typically about 100\(\mu\)V so that thermal smearing was the dominant factor in the resolution of the data. Again, a 300 msec time constant on the lock-in amplifier was used, and the data was swept as slowly as possible, taking almost an hour to sweep from 0 to 50mV. Initially, data was taken with the SnCu film biased both negatively and positively. However, the junctions are not symmetric about zero bias\(^12\), as can easily be seen in Figure 2, which is a plot of

![FIG. 1. Raw data for the normal state and superconducting state first derivative.](image1)

![FIG. 2. The normal state first derivative raw data.](image2)
the normal state raw data. Because the junction resistance changes much more rapidly with the SnCu film biased negatively, the signal-to-noise ratio for this polarity is lower. Thus, since each polarity contained identical information, only the positively biased data was used.

The normal state first derivative was obtained by heating the substrate above the transition temperature. Since the SnCu film has a resistance in this state, this causes a small displacement of the measured first derivative above or below that measured for the superconducting state, depending on the resistivity of the film as compared to the junction resistance. Consequently, one must manually shift the data so that it matches the superconducting state at high bias voltages. Therefore, data was taken up to a bias voltage much higher than the maximum phonon energy. Thus, both the normal and superconducting state data were smoothed and interpolated with an increment of 0.05 mV. The average difference was then calculated from 40 mV to 50 mV, and the result used to adjust the normal state data. The tunneling density of states is then given by equation (3).

![Graph](image)

**FIG. 3.** Transition temperature as a function of copper concentration. The filled circles are from this study, the triangle is from Knorr and Barth, and the open circles are from Leitz, and the squares are from Dutzi and Buckel.

**IV. RESULTS AND DISCUSSION**

Measurement of the superconducting transition temperature agree very well with that of others, as seen in Figure 3. Thus, the linear dependence of $T_c$ on the copper concentration is confirmed.

Table I shows the results of the tunneling analysis, where

$$\lambda = 2 \int_0^\infty \alpha^2(\omega) F(\omega) \omega^{-1} \, d\omega$$

$$\langle f(\omega) \rangle = \frac{2}{\lambda} \int_0^\infty \alpha^2(\omega) F(\omega) f(\omega) \omega^{-1} \, d\omega$$

$$\omega_{\text{log}} = \exp(\ln\omega)$$

$\omega_{\text{min}}$ is the minimum frequency for which there is useful tunneling data. Also, the value of $\mu^*$ obtained from the inversion program is scaled to the arbitrary integration cutoff frequency $\omega_{co}$, but $\mu^*(\omega_{ph})$ is the parameter appropriate for calculating $T_c$. It has been rescaled to the phonon cutoff frequency $\omega_{ph}$ by

$$\frac{1}{\mu^*(\omega_{ph})} = \frac{1}{\mu^*(\omega_{co})} + \ln \left( \frac{\omega_{co}}{\omega_{ph}} \right)$$

Therefore, all values reported will be $\mu^*(\omega_{ph})$.

In Figure 4, $2\Delta_0/k_B T_c$ and $\lambda$ are plotted as a function of copper concentration. Both $2\Delta_0/k_B T_c$ and $\Delta_0$ decrease linearly with increasing copper concentration. Even at 41 at.% copper, the value of $2\Delta_0/k_B T_c$ is still well above the weak-coupling BCS value of 3.52. The variables in Dynes' equation for $T_c$ are $\lambda$, $\mu^*$, and $\langle \omega \rangle$. Values of $\lambda$ determined from the tunneling measurements decrease with Cu concentration, while $\mu^*$ appears to be relatively constant (Table I) at about 0.10, which is quite different from the value of 0.04 found by Knorr and Barth. $\langle \omega \rangle$ increases with increasing copper concentration, which could be expected since the average mass per atom is decreasing. Values of $\lambda$ at higher Cu concentrations deduced from values of $T_c$ and $\theta_D$ with the McMillan equation also decrease with Cu concentration, but the concentration dependence is much weaker than that determined from tunneling measurements on the lower Cu concentration alloys, and there is a large discrepancy in the magnitude of $\lambda$ determined in the tunneling measurements and that inferred from $\theta_D$ and $T_c$ in the one region where the Cu concentrations are similar. This illustrates the now well known fact...
TABLE I. Tunneling results. $R_j$ is the junction resistance at 20meV. $\omega_{\text{min}}$ is the minimum energy for which there is useful tunneling data. The other quantities are defined in the text. The parameters $\omega_{\text{min}}$, $\omega_{\text{ph}}$ and $\omega_{\text{co}}$ are given with respect to the energy gap edge, $\Delta_0$.

<table>
<thead>
<tr>
<th>Sample</th>
<th>SnCu#34-1</th>
<th>SnCu#35-4</th>
<th>SnCu#35-13</th>
<th>SnCu#28-4</th>
<th>SnCu#40-3</th>
<th>SnCu#42-3</th>
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<tbody>
<tr>
<td>Concentration</td>
<td>SnCu0.93Cu0.08</td>
<td>SnCu0.95Cu0.12</td>
<td>SnCu0.97Cu0.13</td>
<td>SnCu0.78Cu0.22</td>
<td>SnCu0.77Cu0.28</td>
<td>SnCu0.59Cu0.41</td>
</tr>
<tr>
<td>$T_c$ (K)</td>
<td>6.865</td>
<td>6.332</td>
<td>6.302</td>
<td>6.283</td>
<td>5.585</td>
<td>5.068</td>
</tr>
<tr>
<td>$R_j$ (Ω)</td>
<td>50</td>
<td>117</td>
<td>57</td>
<td>65</td>
<td>50</td>
<td>168</td>
</tr>
<tr>
<td>$\Delta_0$ (meV)</td>
<td>1.348</td>
<td>1.216</td>
<td>1.200</td>
<td>1.205</td>
<td>1.03</td>
<td>0.906</td>
</tr>
<tr>
<td>$2\Delta_0/k_BT_c$</td>
<td>4.557</td>
<td>4.457</td>
<td>4.437</td>
<td>4.432</td>
<td>4.280</td>
<td>4.149</td>
</tr>
<tr>
<td>Leakage (%)</td>
<td>1.4</td>
<td>1.2</td>
<td>0.9</td>
<td>0.9</td>
<td>4.0</td>
<td>4.5</td>
</tr>
<tr>
<td>$\omega_{\text{min}}$ (meV)</td>
<td>1.40</td>
<td>1.70</td>
<td>1.20</td>
<td>1.60</td>
<td>1.25</td>
<td>1.90</td>
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<tr>
<td>$\omega_{\text{ph}}$ (meV)</td>
<td>21</td>
<td>23</td>
<td>24</td>
<td>24</td>
<td>23</td>
<td>24</td>
</tr>
<tr>
<td>$\omega_{\text{co}}$ (meV)</td>
<td>110</td>
<td>110</td>
<td>110</td>
<td>220</td>
<td>110</td>
<td>110</td>
</tr>
<tr>
<td>$\lambda$</td>
<td>1.80</td>
<td>1.72</td>
<td>1.78</td>
<td>1.73</td>
<td>1.35</td>
<td>1.33</td>
</tr>
<tr>
<td>$\mu^*(\omega_{\text{ph}})$</td>
<td>0.089</td>
<td>0.114</td>
<td>0.118</td>
<td>0.116</td>
<td>0.079</td>
<td>0.113</td>
</tr>
<tr>
<td>$(\omega)$ (meV)</td>
<td>4.656</td>
<td>4.965</td>
<td>4.890</td>
<td>4.925</td>
<td>5.215</td>
<td>5.504</td>
</tr>
<tr>
<td>$(\omega^2)^{1/2}$ (meV)</td>
<td>6.296</td>
<td>6.667</td>
<td>6.519</td>
<td>6.624</td>
<td>6.861</td>
<td>7.193</td>
</tr>
<tr>
<td>$\omega_{\log}$ (meV)</td>
<td>2.750</td>
<td>2.993</td>
<td>2.838</td>
<td>2.961</td>
<td>3.222</td>
<td>3.456</td>
</tr>
</tbody>
</table>

The functions $f_1$ and $f_2$ are fairly close to unity for the case of SnCu, so this essentially changes the prefactor to involve $\omega_{\log}$ instead of $(\omega)$. However, $\omega_{\log}$ has a dependence on copper concentration similar to that of $\omega$.

Figure 5 shows the prediction of the $T_c$ using both equation (2) and equation (7). Neither equation gives very accurate results. Equation (2) consistently overestimates $T_c$ by as much as 20%, whereas equation (7) consistently underestimates it. Thus, caution also should be used in routinely relying on these equations to find the microscopic parameters of a superconductor given its $T_c$.

Figure 6 shows plots of the $\alpha^2 F(\omega)$ data found for the amorphous SnCu films in this study. As can be seen, $\alpha^2 F(\omega)$ is smeared out with increasing copper concentration. There is definitely a shift to higher energies of the low energy structure, as well as an overall decrease in amplitude. The peak at $\sim 1.3$meV also disappears. Whether this is due to a shift to lower energies, or only to a broadening and decrease in amplitude, cannot be determined.
As mentioned previously there is a minimum energy, \( \omega_{\text{min}} \), above the gap edge up to which the experimental tunneling data is not useful. One cause of this is the effect of a non-zero temperature. The inversion program uses the \( T = 0 \) equations to obtain its results. Thus, temperature broadening, and especially taking the superconducting data at a temperature that is an appreciable fraction of the transition temperature, is not taken into account by the program. This will have the greatest effect near the gap as the data is changing rapidly there. The other major cause is the difficulty in taking data near the gap. The data was taken as a function of bias voltage by sweeping a DC current through the junction. Thus, there is a constantly changing bias voltage. This, coupled with the use of a lock-in amplifier, always results in a small offset and smearing of the data no matter how slowly the data is taken. In this respect, it would be better to use a computer-controlled voltage source that was sufficiently free of noise. Again, since the data is changing very rapidly near the gap edge, the largest effect would be seen there. Since it is not really possible to say at what point the data is good, the parameter \( \omega_{\text{min}} \) is somewhat arbitrary. Generally, it is set to the maximum energy that still gives a smooth \( \alpha^2 F(\omega) \) and doesn’t add any extraneous structure. Again, this is somewhat arbitrary, so the additional condition that it maximizes the fit to the tunneling data was used.

Because the tunneling data is not used up to \( \omega_{\text{min}} \), a functional form for \( \alpha^2 F(\omega) \) must be used for this region. For most materials, this form is \( \omega^2 \) and comes from the Debye theory for \( F(\omega) \), assuming that \( \alpha^2(\omega) \) is constant. This is usually a good approximation; however, for the SnCu films of this study, it was necessary to use \( \alpha^2 F(\omega) \propto \omega \) to fit the tunneling data. Knorr and Barth\(^4\) also needed a linear dependence on \( \omega \) for \( \alpha^2 F(\omega) \) at low energies for amorphous Sn\( \_0.5 \)Cu\( \_0.1 \). Their results prompted theoretical studies for amorphous s–p superconductors\(^4\)–\(^6\) which resulted in the following theoretical expression for \( \alpha^2 F(\omega) \) at low frequency,

\[
\alpha^2 F(\omega) = \frac{e^2 E_\pi k_F N(0)p}{3\pi^3(v^3)mM}\omega \equiv A\omega 
\]

where \( N(0) \) is the electronic density of states at the Fermi energy in states/eV-atom-spin, \( p \) is the resistivity, \( M \) is the atomic weight, \( m \) is the electronic mass, and \( v \) is the speed of sound. The assumption of small \( q \) such that \( \omega = vq \) for the phonons has been made, and

FIG. 5. Comparison between experimental and calculated values for \( T_c \). The filled circles are experimental values from this study. The open circles are calculated using equation (7), and the open squares are calculated using equation (2).

FIG. 6. \( \alpha^2 F(\omega) \) as a function of energy showing the data for copper concentration \( x = 0.08, 0.28, 0.41 \).
\[ \frac{1}{\langle v^3 \rangle} = \frac{1}{3} \left( \frac{1}{v_z^3} + \frac{2}{v_t^3} \right) \]

where \( v_z \) and \( v_t \) are the longitudinal and transverse sound velocities, respectively. Following the approximations made by Poon and Geballe\(^{15}\), the free electron model is used to obtain

\[ E_F = \frac{\hbar^2 k_F^2}{2m} \]
\[ N(0) = \frac{mk_F}{\pi^2\hbar^2} \frac{M}{\rho_m A_o} \]

with \( \rho_m \) being the mass density of the alloy, and \( A_o \) is Avogadro's number. Also, \( \langle v^3 \rangle \propto M\theta_D^2/\rho_m \); thus,

\[ A \propto \frac{\hbar^3 k_F^5 \rho A_o}{6\pi^5 m M\theta_D^3} \]  

(9)

Poon and Geballe\(^{15}\) then determined the constant of proportionality for PbBi with known values of \( \theta_D \) and \( \langle v^3 \rangle \) which they assumed was the same for amorphous SnCu, 11.56. This can then be written in terms of \( \langle \omega \rangle \) using McMillan's \( T_c \) equation by \( \theta_D = 1.45\langle \omega \rangle/1.20 \). Thus,

\[ A = \frac{11.56\hbar^3 k_F^5 \rho A_o}{6\pi^5 m M\langle \omega \rangle^3} \left( \frac{1.20}{1.45} \right)^3 \]  

(10)

The Fermi wavevector, \( k_F \), is given by

\[ k_F = \sqrt{\frac{3\pi^2 Z\eta_o}{m}} \]
\[ Z = (1-x)Z_{\text{Sn}} + xZ_{\text{Cu}} \]

where \( Z_{\text{Sn}} \) and \( Z_{\text{Cu}} \) are the valences of the pure elements counting s- and p- states only, one for copper and four for tin. The mean number of atoms per unit volume is \( \eta_o \) and is given by

\[ \eta_o^{-1} = (1-x) \frac{M_{\text{Sn}}}{A_o\rho_{\text{Sn}}} + x \frac{M_{\text{Cu}}}{A_o\rho_{\text{Cu}}} \]

where \( M_i \) and \( \rho_i \) are the atomic weights and the mass densities of the pure elements.

This allows calculation of the slope of \( \alpha^2 F(\omega) \) to be made. Figure 7 shows a comparison between these calculations (open circles) and experimental data (closed circles) from this study. The agreement is surprisingly good considering the number of approximations made. However, this agreement is probably fortuitous, since use of values for \( \theta_D \) from recent heat capacity measurements\(^{17}\) in equation (9) gives very poor agreement (the open squares of Figure 7). Figure 8 shows \( \theta_D \) data from the heat capacity measurements by Dutzi and Buckel\(^6\) and Sohn\(^{17}\) and \( \langle \omega \rangle \) converted to \( \theta_D \) using the ratios of equations (1) and (2), i.e. \( \theta_D = 1.45\langle \omega \rangle/1.20 \). As seen in the figure, this commonly used relation is not valid for the amorphous SnCu system.

More fundamental than the question of what parameters to use in the calculation of \( A \) from equations (8) or (9) is the question of whether \( \alpha^2 F(\omega) \) is really linear in \( \omega \) at low frequency. Belitz\(^{18}\) has pointed out that the derivation of equation (8) is based on incorrect assumptions and has derived the following expressions for \( \alpha^2 F(\omega) \) at low frequency,

\[ \alpha^2 F(\omega) = \frac{\hbar^2 k_F^3}{q_D^3} \left[ \frac{4k_F}{\pi^2} F + O(\rho^2) \right], \left( \omega/\omega_D \ll \eta \right) \]

where
FIG. 7. Slope of $\alpha^2 F(\omega)$ as a function of copper concentration. The filled circles are experimental values from this study, the filled square is from Knorr and Barth\(^8\), the open circles are calculated values using equation (10), and the open squares are calculated values using equation (9).

\[
F = \int_0^\infty dx [\pi^2/36 - f_1^2(z)/z^2 - (v_t/v_l)^4 f_1^2(x)/x^2]
\]

\[
f_1(x) = \frac{1}{3} \frac{x^2 \arctan z}{x - \arctan z} - 1
\]

\[
f_1(x) = \frac{1}{2x^3}[2x^3 + 3x - (3x^2 + 1)\arctan z] ;
\]

\[
\alpha^2 F(\omega) = \hbar_1 q_D / k_F \left( \frac{3}{2} v_l^5 / v_t^5 \right)(\omega / \omega_D)^3, \quad (\eta \ll \omega / \omega_D \ll \tilde{\rho} k_F / q_D),
\]

\[
\alpha^2 F(\omega) = \hbar_1 \left( \omega / \omega_D \right)^2 + k_F / q_D \pi \left[ 12 v_l^3 / v_t^3 - (8 - \pi^2 / 2) \tilde{\rho} \omega / \omega_D \right]; (\tilde{\rho} k_F / q_D \ll \omega / \omega_D \ll \tilde{\rho} 2 E_F / \omega_D)
\]

where $\eta = k_F^4 / 9 \rho m v$, $h_1 = h^4 k_F^2 q_D^2 N(0) / 36 m^2 \rho_m v_l^2$, $\tilde{\rho} = 1 / k_F l$. Thus, $\alpha^2 F(\omega)$ is essentially linear with $\omega$ except for the range $(\eta \ll \omega / \omega_D \ll \tilde{\rho} k_F / q_D)$ for which it goes as $\omega^3$. For the SnCu films in this study, $\eta \sim 0.057$ and $\tilde{\rho} k_F / q_D \sim 0.48$meV. Unfortunately, this range is smaller than the minimum energy for which the data of this study is reliable; so, the $\omega^3$ region cannot be directly observed. This theory also involves $v_t$, $v_l$ and $\theta_D$ which are unknown for the amorphous SnCu films of this study. An attempt was made to set $\alpha^2 F(\omega)$ proportional to $\omega^3$ up to 0.5meV and then proportional to $\omega$ up to $\omega_{\text{min}}$ when doing the tunneling analysis. This invariably lead to an $\alpha^2 F(\omega)$ and $\mu^*$ which didn’t reproduce the tunneling data, as demonstrated in Figures 9 and 10 for Sn_{0.87}Cu_{0.13}. Figure 9 shows the resulting $\alpha^2 F(\omega)$. In Figure 10 curve (a) shows the difference between the experimental tunneling density of states and the calculated density of states. There is a large difference, whereas when $\alpha^2 F(\omega)$ is assumed to be proportional to $\omega$ up to $\omega_{\text{min}}$, the difference is about $1 \times 10^{-3}$, as shown in curve (b). Also, $\mu^*(\omega_{ph})$ and $\lambda$ are 0.07 and 1.46, respectively, compared with the previous results of 0.116 and
1.73. Consequently, this tunneling data is best fit by a purely linear \( \omega \) dependence for \( \alpha^2 F(\omega) \) at low frequency in these alloys.

A material for which the range of the predicted \( \alpha^2 F(\omega) \propto \omega^3 \) is large and at high enough energies that very accurate data can be measured would allow direct observation of the low frequency \( \alpha^2 F(\omega) \) spectrum to see if an \( \omega^3 \) dependence exists. We are unaware of such a material. Efforts to incorporate the predicted \( \omega^3 \) dependence to fit the present tunneling data were totally unsuccessful. However, it should be pointed out that Belitz's theory may be correct within the framework in which it is derived, and that this study is perhaps seeing a breakdown in the fundamental assumptions upon which this theory is based. One speculation is that perhaps the adiabatic approximation breaks down at this level of detailed measurement in such strong-coupling metals.

V. SUMMARY AND CONCLUSIONS

Amorphous Sn\(_{1-x}\)Cu\(_x\) thin films (0.08 \( \leq x \leq 0.41 \)) were prepared by e-beam deposition in an ultra-high vacuum system, forming high quality aluminum – aluminum oxide – superconductor tunnel junctions. Measurements of the transition temperature, \( T_c \), were in excellent agreement with work done by others, confirming the linear decrease in \( T_c \) with increasing \( x \). The superconducting energy gap, \( \Delta_0 \), and \( 2\Delta_0/k_B T_c \) show a linear decrease with increasing \( x \); however, \( 2\Delta_0/k_B T_c \) was 3.982, well above the BCS prediction of 3.52, and \( \lambda = 1.01 \) for \( x = 0.41 \), suggesting that this alloy composition is still a strong-coupling to intermediate-coupling superconductor.

![Graph of \( \alpha^2 F(\omega) \) vs Energy](image1)

**FIG. 9.** \( \alpha^2 F(\omega) \) as a function of energy for sample SnCu#35-4 (Sn\(_{0.87}\)Cu\(_{0.13}\)). \( \alpha^2 F(\omega) \) was assumed to be proportional to \( \omega^3 \) up to 0.5meV and then proportional to \( \omega \) up to \( \omega_{\text{min}} \).

![Graph of experimental vs theoretical](image2)

**FIG. 10.** Difference between the experimental and calculated tunneling density of states as a function of energy when \( \alpha^2 F(\omega) \) was assumed to be (a) proportional to \( \omega^3 \) up to 0.5meV and then proportional to \( \omega \) up to \( \omega_{\text{min}} \), and (b) linear up to \( \omega_{\text{min}} \).

The Coulomb pseudopotential is approximately independent of \( x \), \( \mu^*(\omega_{\text{ph}}) = 0.10 \pm 0.02 \); \( \lambda \) decreases while \( \langle \omega \rangle \) increases with \( x \), indicating that \( \lambda \) is the cause for the decrease in transition temperature with \( x \). The experimental values for \( T_c \) were compared to the theories of Dynes\(^8\) and Allen and Dynes\(^9\). Neither formula provided quantitative agreement, suggesting that these formulae should not be routinely used to extract the microscopic parameters of a superconductor given its \( T_c \).

A linear dependence on \( \omega \) for \( \alpha^2 F(\omega) \) at small \( \omega \) was needed to reproduce the experimental tunneling spectra in contrast to the most recent predictions which require a small region proportional
to $\omega^3$. The shape of $\alpha^2 F(\omega)$ changed from two distinct peaks at low $x$, to one smeared peak at $x = 0.41$. The reason for this qualitative change in the shape of $\alpha^2 F(\omega)$ has not been determined.

Future work needs to be done to explore better the change from strong-coupling to weak-coupling behavior in more copper rich alloys and to better test the theories of the behavior of $\alpha^2 F(\omega)$ at low frequency. This could be useful in resolving the disagreement between the theory of Belitz\textsuperscript{18} and present data on amorphous alloys. To date there is no experimental confirmation of the detailed predictions for the low frequency behavior of $\alpha^2 F(\omega)$ for strong-coupling superconductors given by this state of the art theory. A clear test will require much more accurate tunneling data near the energy gap and a strong-coupling superconductor with a broader region for the predicted $\omega^3$ behavior.

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